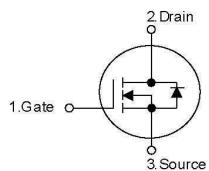


**4 Amps, 600Volts****N-CHANNEL MOSFET****■ DESCRIPTION**

The SSS5N60 is a high voltage MOSFET and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and have a high rugged avalanche characteristics. This power MOSFET is usually used at high speed switching applications in power supplies .PWM motor controls, high efficient DC to DC converters and bridge circuits.

■ FEATURES

- $R_{DS(ON)}=2.5\ \Omega @V_{GS}=10V$
- Ultra Low gate charge(typical 15.0nC)
- Low reverse transfer capacitance($C_{RSS}=\text{typical} 8.0\text{pF}$)
- Fast switching capability
- Avalanche energy specified
- Improved dv/dt capability,high ruggedness

■ SYMBOL**■ ORDERING INFORMATION**

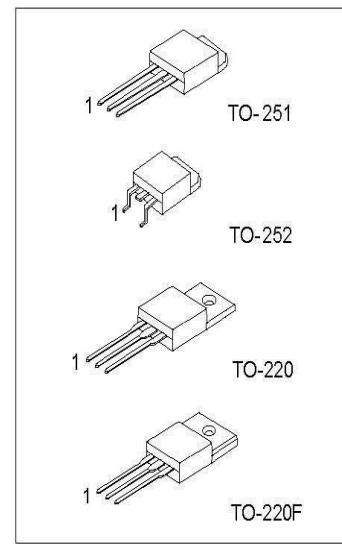
Order Number		Package	Pin Assignment			Packing
Normal	Lead Free Plating		1	2	3	
5N60-TA3-T	5N60L-TA3-T	TO-220	G	D	S	Tube
5N60-TF3-T	5N60L-TF3-T	TO-220F	G	D	S	Tube
5N60-TM3-T	5N60L-TM3-T	TO-251	G	D	S	Tube
5N60-TN3-R	5N60L-TN3-R	TO-252	G	D	S	Tape Reel
5N60-TN3-T	5N60L-TN3-T	TO-252	G	D	S	Tube

Note:Pin Assignment: G:Gate D:Drain S:Source

 (1) Packing Type (2) Package Type (3) Lead Plating	(1)T:Tube,R:Tape Reel
	(2)TA3:TO220,TF3:TO-220F,TM3:TO-251,TN3:TO-252
	(3)L:Lead Free Plating Blank: Pb/Sn

■ ABSOLUTE MAXIMUM RATINGS ($T_c=25^\circ\text{C}$, unless otherwise specified)

PARAMETER		SYMBOL	PATINGS	UNIT
Drain-Source Voltage		V_{DSS}	600	V
Gate-Source Voltage		V_{GSS}	± 30	V
Avalanche Current(Note 2)		I_{AP}	4.4	A
Drain Currentet Continuous	$T_c=25^\circ\text{C}$	I_D	4.0	A
	$T_c=100^\circ\text{C}$		2.5	A
Drain Current Pulsed(Note 2)		I_{DP}	16	A



*Pb-free plating product number: 2N60L



Avalanche Energy	Repetitive(Note 2)	E_{AR}	260	mJ
	Single Pulse(Note 3)	E_{AS}	10.6	mJ
Peak Diode Recovery dv/dt(Note 4)		dv/dt	4.5	v/ns
Total Power Dissipation	$T_c=25^\circ C$	P_D	75	W
	Derate above $25^\circ C$		0.59	W/ $^\circ C$
Junction Temperature		T_J	+150	$^\circ C$
Storage Temperature		T_{STG}	-55~+150	$^\circ C$

Note:1.Absolute maximum ratings are those values beyond which the device could be permanently damaged

Absolute maximum ratings are stress ratings only and functional device operation is not implied

2.Repetitive Rating:Pulse width limited bu maximum junction temperature

■ THERMAL DATA

PARAMETER	PACKAGE	SYMBOL	RATINGS	UNIT
Thermal Resistance Junction-Ambient	TO-251	θ_{JA}	83	$^\circ C/W$
	TO-252		83	
	TO-220		62.5	
	TO-220F		62.5	
Thermal Resistance Junction-Case	TO-251	θ_{JC}	2.5	$^\circ C/W$
	TO-252		2.5	
	TO-220		1.18	
	TO-220F		3.47	

■ ELECTRICAL CHARACTERISTICS($T_J=25^\circ C$, unless Otherwise specified.)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNI
Off Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	600			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=600V, V_{GS}=0V$			10	μA
		$V_{DS}=480V, T_c=125^\circ C$			100	μA
Gate-Body Leakage Current	I_{GSS}	$V_{GS}=30V, V_{DS}=0V$			100	nA
		$V_{GS}=-30V, V_{DS}=0V$			-100	nA
Breakdown Voltage Temperature	$\Delta BV_{DSS}/\Delta T_J$	$I_D=250\mu A$		0.6		V/ $^\circ C$
On Characteristics						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	2.0		4.0	V
Static Drain-Source On-Resistance	$R_{DS(ON)}$	$V_{DS}=10V, I_D=2.2A$			2.5	Ω
Forward Transconductance	g_{FS}	$V_{DS}=100V, I_D=2.4A$ (Note 1)	2.9			S
Dynamic Characteristics						
Input Capacitance	C_{iss}	$V_{DS}=25V, V_{GS}=0V, f=1MHz$		520	670	pF
Output Capacitance	C_{oss}			70	90	pF
Reverse Transfer Capacitance	C_{rss}			8	11	pF

■ ELECTRICAL CHARACTERISTICS(Cont.)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Switching Characteristics						
Turn-On Delay Time	$t_{D(ON)}$	$V_{DD}=300V, I_D=4.0A, R_G=25\Omega$ (Note1, 2)		13	35	ns
Rise Time	t_R			45	100	ns
Turn-Off Delay Time	$t_{D(OFF)}$			25	60	ns
Fall Time	t_F			35	80	ns
Total Gate Charge	Q_G	$V_{DS}=480V, V_{GS}=10V, I_D=4.0A$		15	20	nC

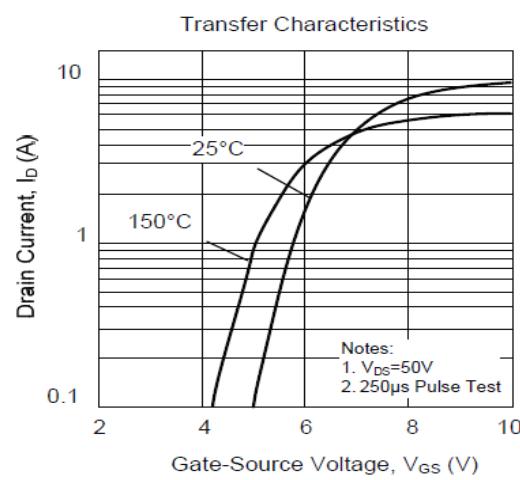
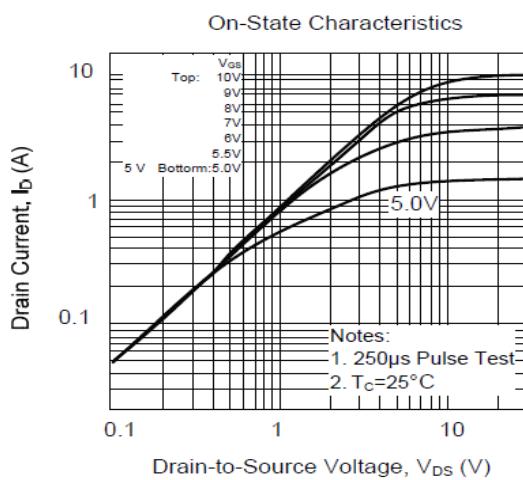
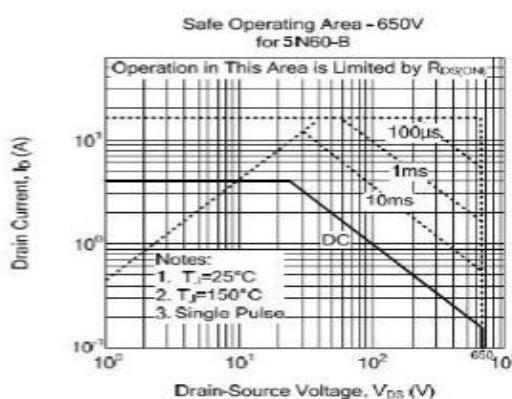
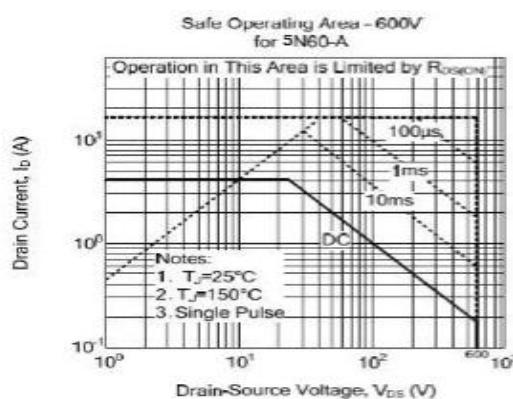
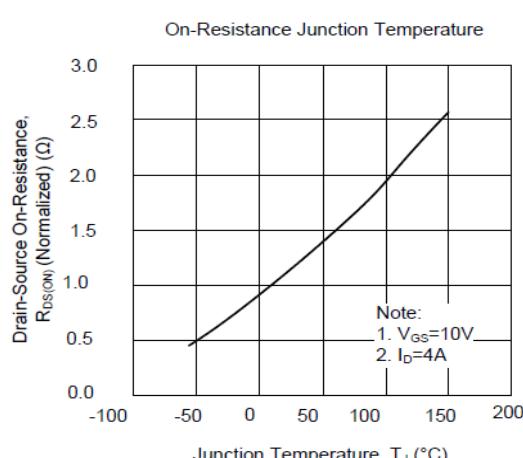
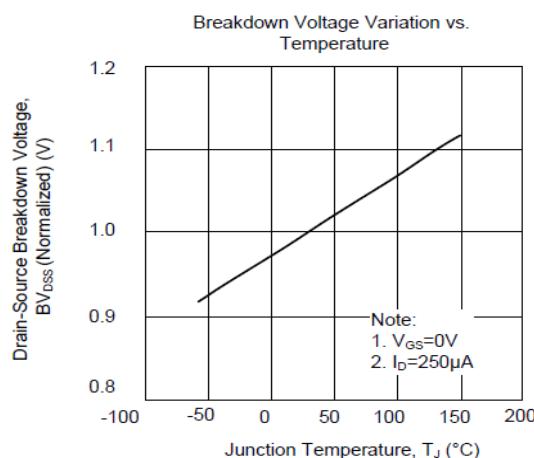


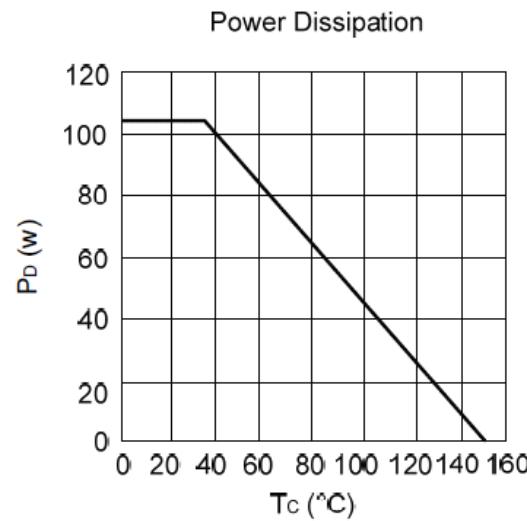
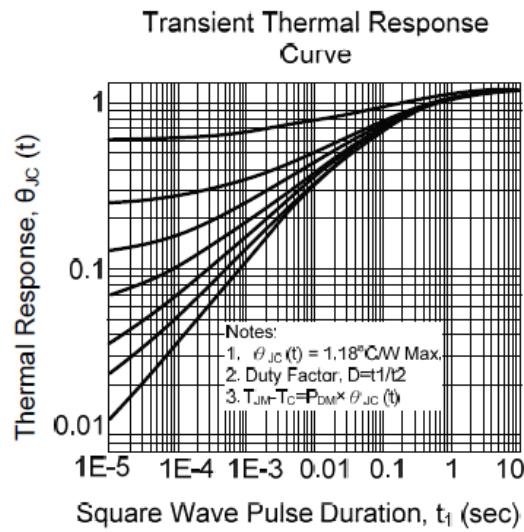
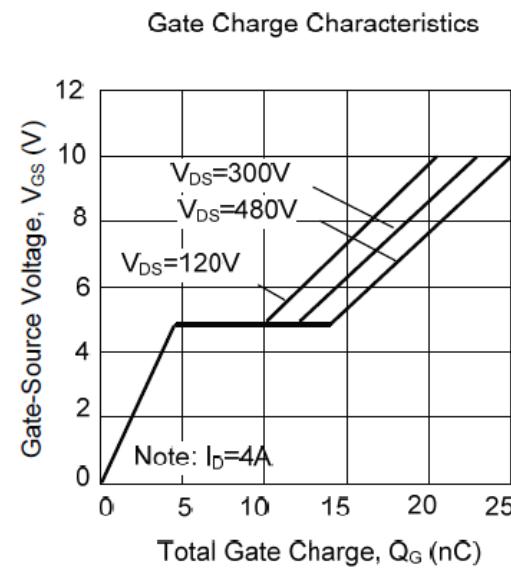
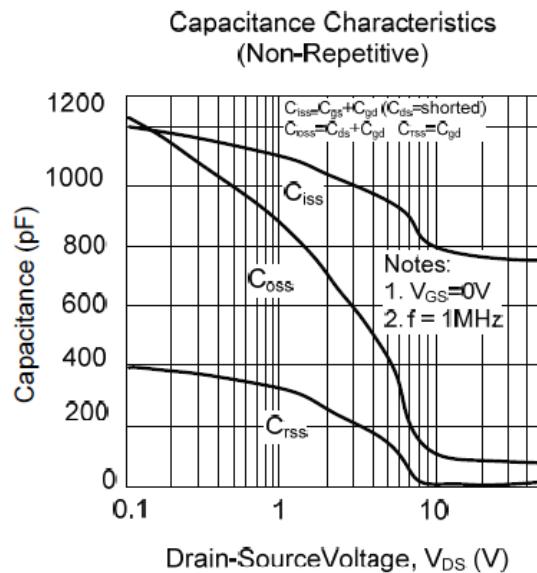
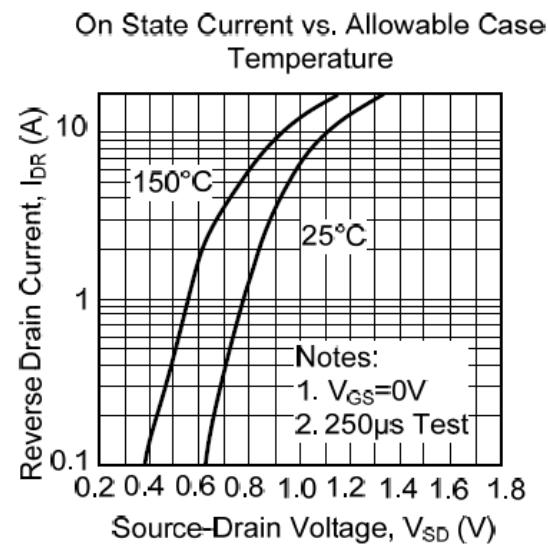
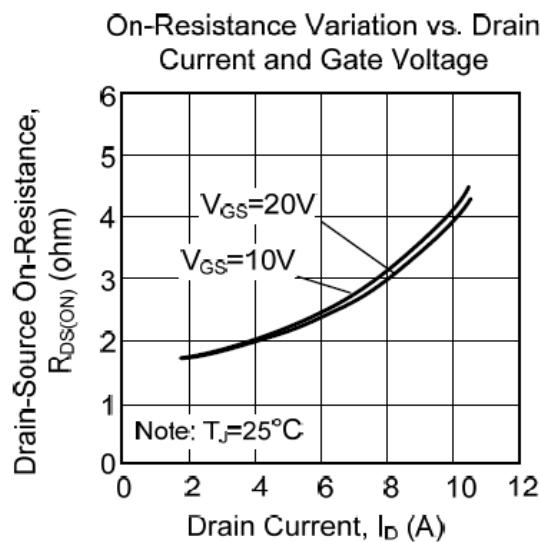
Gate-Source Charge	Q_{GS}	(Note1,2)		3.4		nC
Gate-Drain Charge	Q_{GD}			7.1		nC
Drain-Source Diode Characteristics						
Drain-Source Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_{SD}=4.4A$			1.4	V
Continuous Drain-Source Current	I_{SD}				4.4	A
Pulsed Drain-Source Current	I_{SM}				17.6	A
Reverse Recovery Time	t_{RR}	$V_{GS}=0V, I_{SD}=4.4A,$ $di/dt=100A/\mu A$		250		ns
Reverse Recovery Charge	Q_{RR}			1.5		μC

Note:1. Pulse Test: Pulse Width $\leq 300 \mu s$, Duty Cycle $\leq 2\%$

2. Essentially Independent of Operating Temperature

■ TYPICAL CHARACTERISTICS



**TYPICAL PERFORMANCE CHARACTERISTICS(cont)**

**■ TYPICAL CHARACTERISTICS(cont)**

Maximum Drain Current vs. Case Temperature

